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Information Disclosure Statement By Applicant

(Use Several Sheets if Necessary)

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Applicant: Michel Sayag

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Application No.:

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Group **2878**

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
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Foreign Patent or Published Foreign Patent Application

No EP1037071 (Abstract) - JP11352616 (Abstract) JP2-2955 JP2-66316	Date 09/20/00 12/24/99 01/07/00	Patent Office EPO Japan Japan	Class	class	Yes X	No
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